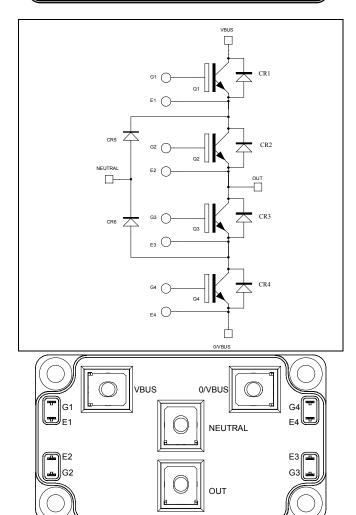


APTGL240TL120G

Three level inverter Trench + Field Stop IGBT4 Power Module



$V_{CES} = 1200V$ $I_{C} = 240A$ @ $Tc = 80^{\circ}C$

Application

- Solar converter
- Uninterruptible Power Supplies

Features

- Trench + Field Stop IGBT 4 Technology
 - Low voltage drop
 - Low leakage current
 - Low switching losses
 - Soft recovery parallel diodes
 - Low diode VF
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
 - Very low stray inductance
 - Symmetrical design
 - M5 power connectors
 - High level of integration

Benefits

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- Stable temperature behavior
- Very rugged
 - Direct mounting to heatsink (isolated package)
 - Low junction to case thermal resistance
 - Easy paralleling due to positive TC of VCEsat
 - Low profile
 - RoHS Compliant

Q1 to Q4 Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		1200	V
т	Continuous Collector Current	$T_c = 25^{\circ}C$	305	
I _C	Continuous Collector Current	$T_c = 80^{\circ}C$	240	А
I _{CM}	Pulsed Collector Current	$T_c = 25^{\circ}C$	400	
V _{GE}	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	1000	W
RBSOA	Reverse Bias Safe Operating Area	$T_{j} = 150^{\circ}C$	400A @ 1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Q1 to Q4 Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V$; $V_{CE} = 1200V$				2	mA
V _{CE(sat)}	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_{C} = 200A$	$T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$		1.8 2.2	2.2	V
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 5 \text{ mA}$		5	5.8	6.5	V

Q1 to Q4 Dynamic Characteristics

Symbol	Characteristic	Test Conditions	5	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			12.3		
C _{oes}	Output Capacitance	$V_{CE} = 25V$			0.8		nF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz			0.69		
Q _G	Gate charge	$V_{GE}=\pm 15V$			1.7		μC
T _{d(on)}	Turn-on Delay Time	Inductive Switc	hing (25°C)		160		
Tr	Rise Time	$V_{GE} = \pm 15V$			30		
T _{d(off)}	Turn-off Delay Time	$V_{CE} = 600V$ $I_{C} = 200A$			340		ns
T _f	Fall Time	$R_G = 3.6\Omega$			80		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{CE} = 600V$ $I_C = 200A$			170		ns
Tr	Rise Time				40		
T _{d(off)}	Turn-off Delay Time				450		
T _f	Fall Time	$R_G = 3.6\Omega$			170		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_J = 25^{\circ}C$		10.4		mJ
2011		$V_{CE} = 600 V$			21		
E _{off}	Turn-off Switching Energy	$R_G = 3.6\Omega$	$T_J = 25^{\circ}C$		11		mJ
-011	······································		$T_{\rm J} = 150^{\circ}{\rm C}$		18.6		
I _{SC}	Short circuit current	$V_{GE} \le 15V$; $V_{CC} = 900V$ $t_p \le 10\mu s$; $T_1 = 150^{\circ}C$			1000		А
R _{thJC}	Junction to Case Thermal Resistance				0.15	°C/W	

CR1 to CR4 diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 400	μA
I _F	DC Forward Current		$Tc = 80^{\circ}C$		180		Α
V	Diada Farryard Valtaga	$I_{\rm F} = 150 {\rm A}$	$T_i = 25^{\circ}C$		1.7	2.2	V
V_{F}	Diode Forward Voltage	$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.65		v
	Descence Descence Times		$T_j = 25^{\circ}C$		155		20
t _{rr}	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		300		ns
0	Pavara Pacavary Charga	$ I_{F} = 150A V_{R} = 600V di/dt = 3800A/\mu s $	$T_j = 25^{\circ}C$		14.6		
Q _{rr}	Reverse Recovery Charge		$T_{j} = 150^{\circ}C$		30.4		μC
Б	Reverse Recovery Energy		$T_j = 25^{\circ}C$		5.2		mJ
E _{rr}	,		$T_{j} = 150^{\circ}C$		11		111J
R _{thJC}	Junction to Case Thermal Resistance					0.32	°C/W

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CR5 & CR6 diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit			
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V		
I _{RM}	Maximum Reverse Leakage Current	V _R =1200V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 400	μΑ		
I _F	DC Forward Current		$Tc = 80^{\circ}C$		240		Α		
V _F	Diode Forward Voltage	$I_F = 200A$	$T_i = 25^{\circ}C$		1.9	2.4	V		
	$v_{GE} = 0V$ $T_1 = 150^{\circ}C$	$V_{GE} = 0V$	$V_{GE} = 0V$ T	$V_{GE} = 0V$	$T_i = 150^{\circ}C$		1.85		
ť	Reverse Recovery Time	$I_F = 200A$ $V_R = 600V$ $T_j = 1$ $T_j = 2$	$T_j = 25^{\circ}C$		155		ns		
t _{rr}	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		300		115		
Q _{rr}	Reverse Recovery Charge		$T_j = 25^{\circ}C$		18.6		μC		
Qm	Reverse Recovery Charge		$T_{j} = 150^{\circ}C$		39		μΟ		
Б	D		$T_j = 25^{\circ}C$		8.2		Im I		
E _{rr}	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		16		mJ		
R _{thJC}	Junction to Case Thermal Resistance					0.25	°C/W		

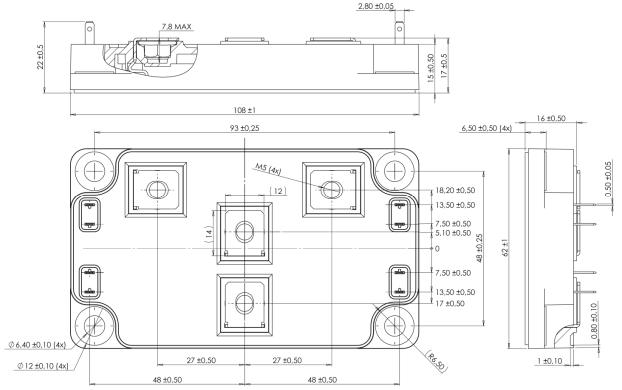
Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		175	
T _{STG}	Storage Temperature Range			-40		125	°C
T _C	Operating Case Temperature					100	
Torque	Mounting torque	To heatsink	M6	3		5	N.m
Torque	Mounting torque For terminals M5		M5	2		3.5	IN.III
Wt	Package Weight					300	g

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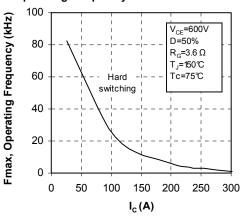


SP6 Package outline (dimensions in mm)

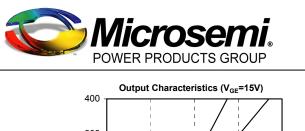


See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

Q1 to Q4 Typical performance curve

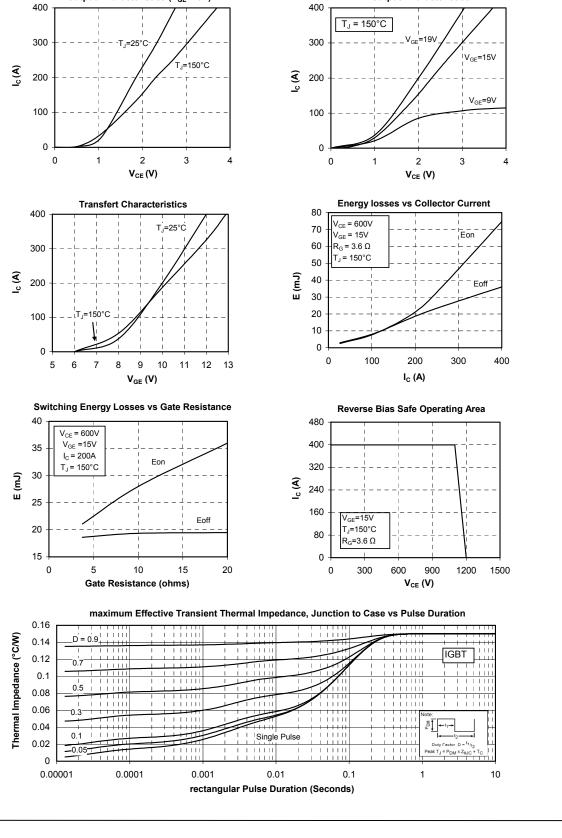


Operating Frequency vs Collector Current



APTGL240TL120G

Output Characteristics

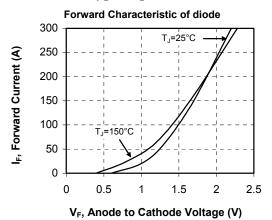


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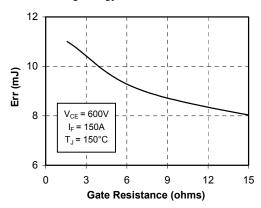
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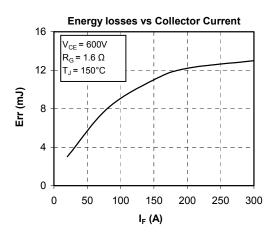


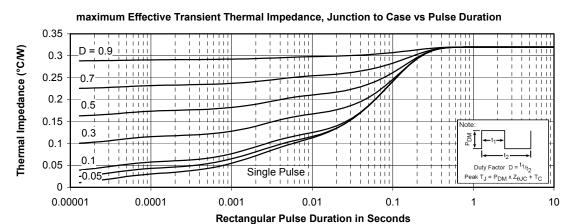
CR1 to CR4 Typical performance curve



Switching Energy Losses vs Gate Resistance





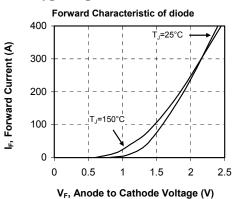


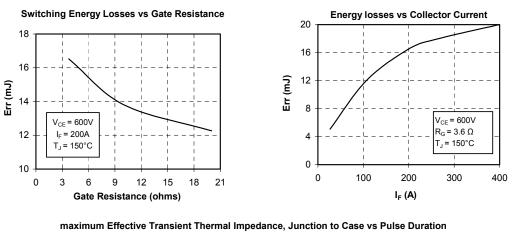


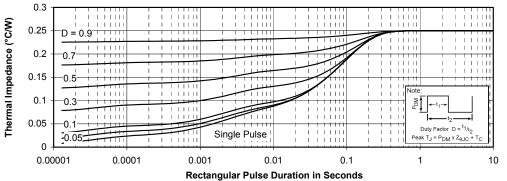
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CR5 & CR6 Typical performance curve







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